



P-Channel 30 V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
- 30	0.020 at V _{GS} = - 10 V	- 12 ^a	15.5 nC			
- 30	0.033 at V _{GS} = - 4.5 V	- 12 ^a	15.5110			

FEATURES

 Halogen-free According to IEC 61249-2-21 Definition

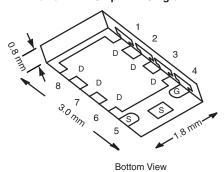


- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm profile
- Compliant to RoHS Directive 2002/95/EC



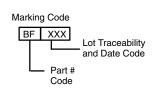
ROHS COMPLIANT HALOGEN FREE

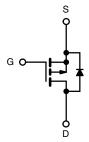
PowerPAK® ChipFET® Single



APPLICATIONS

Load Switch





P-Channel MOSFET

Ordering Information: Si5419DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATIN	I GS (T _A = 25 °C	, unless oth	erwise noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		- 12 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	l _D	- 12 ^a		
Continuous Brain Current (1) = 100 °C)	T _A = 25 °C	d' 'D	- 9.9 ^{b, c}		
	T _A = 70 °C]	- 7.9 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 40		
Continuous Source-Drain Diode Current	T _C = 25 °C		- 12 ^a		
Continuous Cource Diam Blode Current	T _A = 25 °C	I _S	- 2.6 ^{b, c}		
	T _C = 25 °C		31		
Maximum Power Dissipation	T _C = 70 °C	P _D	20	w	
Maximum Fower Dissipation	T _A = 25 °C		3.1 ^{b, c}	•	
	T _A = 70 °C		2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RA	AL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3	4	O/ VV	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.



SPECIFICATIONS ($T_J = 25 ^{\circ}C$) Parameter	Symbol	Test Conditions	Min	Tvn	May	I Init
	Symbol	lest Conditions	Min.	Тур.	Max.	Unit
Static Service Provide National Valley	.,	V 0VI 050 VA	- 30		I	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$				V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = - 250 μA		- 20		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	- 1.2		- 2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ
	1000	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 5	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, $V_{GS} =$ - 4.5 V	- 20			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -10 \text{ V}, I_D = -6.6 \text{ A}$		0.016	0.020	0
Diam course on state resistance	US(on)	$V_{GS} = -4.5 \text{ V}, I_D = -5.1 \text{ A}$		0.027	0.033	V nA — μA
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 6.6 A		20		S
Dynamic ^b						
Input Capacitance	C _{iss}			1400		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		240		pF
Reverse Transfer Capacitance	C _{rss}			200		
Total Octo Observe	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -9.9 \text{ A}$ 30	30	45			
Total Gate Charge	Q_{g}			15.5	24	0
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.9 \text{ A}$		4.5		nC
Gate-Drain Charge	Q _{gd}			7.5		
Gate Resistance	R_g	f = 1 MHz		6.7		Ω
Turn-on Delay Time	t _{d(on)}			47	70	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_1 = 1.9 \Omega$		33	50	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -7.9 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		30	45	
Fall Time	t _f			16	25	
Turn-On Delay Time	t _{d(on)}			10	15	ns
Rise Time	t _r	$V_{DD} = -15 \text{ V, R}_{L} = 1.9 \Omega$		10	15	1
Turn-Off Delay Time	t _{d(off)}	$I_D \simeq -7.9 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		40	60	1
Fall Time	t _f			12	20	1
Drain-Source Body Diode Characterist					<u> </u>	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 12	
Pulse Diode Forward Current	I _{SM}	, , ,			40	Α
Body Diode Voltage	V _{SD}	I _S = - 7.9 A, V _{GS} = 0 V		- 0.85	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	3 / 43 -		25	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}			15	25	nC
Reverse Recovery Fall Time	t _a	$I_{\rm F} = -7.9 \text{A}, \text{dI/dI} = 100 \text{A/} \mu \text{S}, I_{\perp I} = 25 \text{G}$		11		<u> </u>
Reverse Recovery Rise Time	t _a	1		14		ns

Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- a. Guaranteed by design, not subject to production testing.

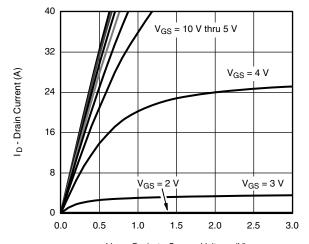
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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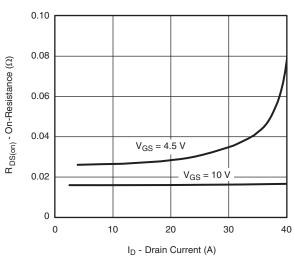


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

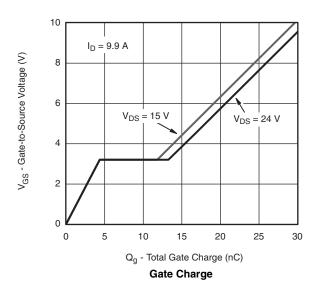


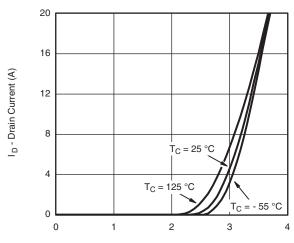
 V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics



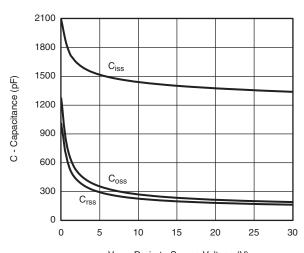
On-Resistance vs. Drain Current





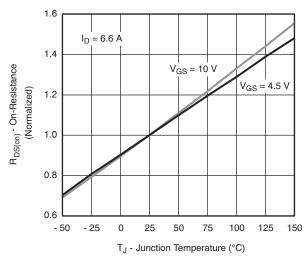
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



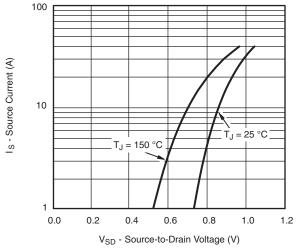
 V_{DS} - Drain-to-Source Voltage (V)

Capacitance

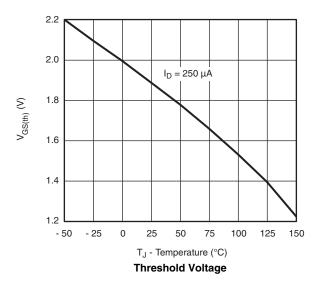


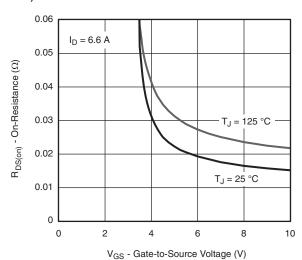
On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

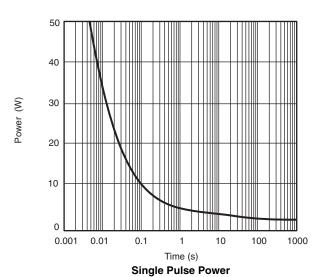


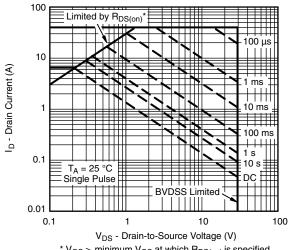
Source-Drain Diode Forward Voltage





On-Resistance vs. Gate-to-Source Voltage





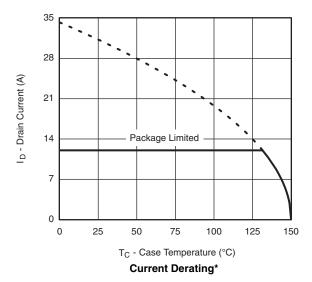
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

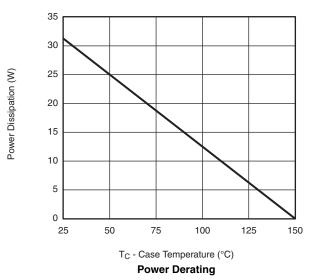
Safe Operating Area





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

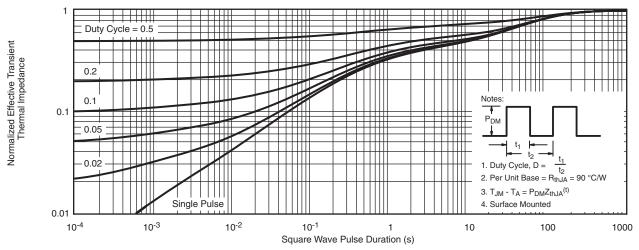




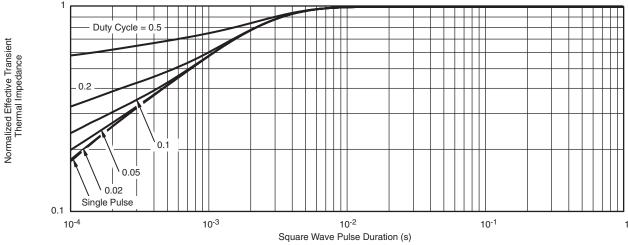
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

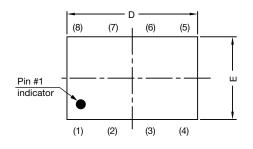


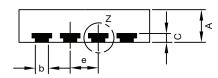
Normalized Thermal Transient Impedance, Junction-to-Case

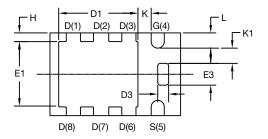
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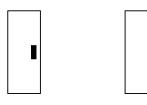
PowerPAK® ChipFET® Case Outline



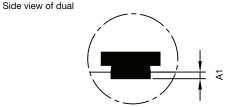




Backside view of single pad



Side view of single



Detail Z

D1(8) D1(7) D2(6) D2(5)

K3

Backside view of dual pad

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC		0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	-	
K1	0.30	-	-	0.012	-	-	
K2	0.20	-	-	0.008	-	-	
K3	0.20	-	-	0.008	-	-	
L	0.30	0.35	0.40	0.012	0.014	0.016	

C14-0630-Rev. E, 21-Jul-14

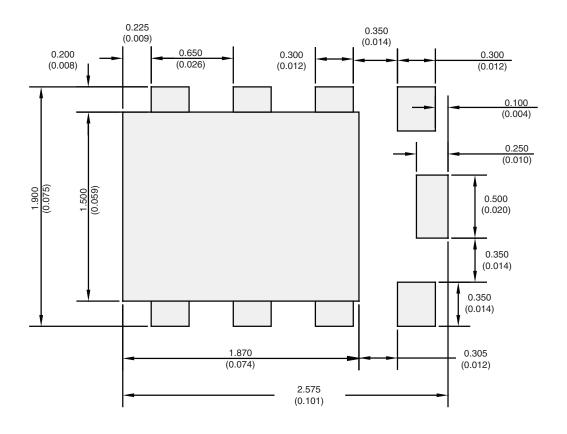
DWG: 5940

• Millimeters will govern

Revision: 21-Jul-14 1 Document Number: 73203



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE

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